Notice of References Cited Application/Control No. O9/760,339 Examiner O9/760,339 Examiner O9/760,339 Examiner O9/760,339 Examiner O9/760,339 Applicant(s)/Patent Under Reexamination CHAPPEL ET AL. Examiner O9/760,339 Examiner O9/760,339

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,553,282	09-1996	Parrish et al.	707/10
	В	US-5,960,196	09-1999	Carrier et al.	717/122
	С	US-5,930,798	07-1999	Lawler et al.	707/102
	D	US-6,073,107	06-2000	Minkiewicz et al.	705/7
	E	US-6,101,481	08-2000	Miller, Neil G.	705/9
	F	US-4,912,669	03-1990	Iwamoto et al.	715/531
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q .					-
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
*	U	Barry Bohem et al., Software Cost Estimation with COCOMO II, Prentice Hall 2000				
	V	Edward Weller, Using Metrics to Manage Software Projects, IEEE Computer, September 1994				
*	w	William Florac et al., Measure the Software Process: Statistical Process Control for Software Process Improvement, Addison-Wesley, July 1999				
	x	Michael Daskalantonakis, A Practical View of Software Measurement and Implementation Experiences within Motorola, IEEE Transactions on Software Engineering, Vol. 18 No. 11, November 1992				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 09/760,339 Examiner Scott L. Jarrett Applicant(s)/Patent Under Reexamination CHAPPEL ET AL. Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			· -
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	NON I AILUI BOOGIILII I				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Juan Nogueira et al., A Formal Risk Assesment model for Software Evolution, US Army Research Office grant# 38690-MA and 40473-MA.			
	V	Raymon Paul et al., Software Metrics Knowledge and Databases for Project Management, IEEE Transactions on Knowledge and Data Engineering, Vol. 11 No 1, January/Februrary 1999			
	w				
	х				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.